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	Application No. Applicant(s)		
Notice of Allowability	09/576,957	SAKAI ET AL.	\
	Examiner	Art Unit	
	Michael Trinh	2822	$ \mathcal{L}\rangle\rangle$
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85 NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT F of the Office or upon petition by the applicant. See 37 CFR 1.31 1. ▼ This communication is responsive to 2/12/04. 2. ▼ The allowed claim(s) is/are 29-36. 3. ▼ The drawings filed on 24 May 2000 are accepted by the E 4. ▼ Acknowledgment is made of a claim for foreign priority u a) ▼ All b) □ Some* c) □ None of the: 1. ▼ Certified copies of the priority documents hav 2. □ Certified copies of the priority documents hav 3. □ Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received:	ears on the cover sheet which (OR REMAINS) CLOSED in or other appropriate common (RIGHTS). This application is a and MPEP 1308. Examiner. Examiner. Inder 35 U.S.C. § 119(a)-(d) are been received. The been received in Application is a second control of the c	ith the correspondence add In this application. If not inclused unication will be mailed in dusubject to withdrawal from issubject to withdrawal from or (f).	ded e course. THIS sue at the initiative
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONI THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 5. A SUBSTITUTE OATH OR DECLARATION must be subr	MENT of this application.		
INFORMAL PATENT APPLICATION (PTO-152) which give			
6. CORRECTED DRAWINGS (as "replacement sheets") mu			
(a) ☐ including changes required by the Notice of Draftsper	_	w (PTO-948) attached	
1) hereto or 2) to Paper No./Mail Date		nin din office and in of	
(b) ☐ including changes required by the attached Examiner Paper No./Mail Date			
Identifying indicia such as the application number (see 37 CFR each sheet. Replacement sheet(s) should be labeled as such in			ne back) of
7. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT			. Note the
Attachment(s)	E □ NI-4:41:	oformal Datant Application (D	TO 152\
 Notice of References Cited (PTO-892) Dotice of Draftperson's Patent Drawing Review (PTO-948) 		nformal Patent Application (P' Summary (PTO-413),	10-152)
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 Information Disclosure Statements (PTO-1449 or PTO/SB/ Paper No./Mail Date 	∪8), 7. ∐ Examiner's	Amendment/Comment	
4. Examiner's Comment Regarding Requirement for Deposit	8. 🛭 Examiner's	Statement of Reasons for A	llowance
of Biological Material	9.	Michael Ti Primary Exa	

Art Unit: 2822

DETAILED ACTION

*** This office action is in response to Applicant's Amendment filed 02/12/04, in which Claims 1-28 were canceled. Claims 29-36 are pending.

Allowable Subject Matter

- 1. Claims 29-36 are allowed.
- 2. As already of record, the following is an examiner's statement of reasons for allowance: None of the references of record including Murayama (5,412,533), Kudoh et al (5,117,332), Nakamura et al (5,483,415) fairly anticipatively suggest a method for forming a semiconductor device comprising all process limitations as claimed, or in the combination of the references, to fairly make a prima facie obvious case of the claimed invention as recited in claim 29, wherein neither references teach or suggest linearly coating said masking material solution around the entire circumference and heating the solution to form the first masking layer; subjecting an area where a solid electrolyte is formed later to electrochemical forming; further linearly coating the masking solution around the entire circumference at a distance from the first masking layer on the electrochemically formed metal material, and heating the solution to form the second masking layer; forming a solid electrolyte in the are exclusive of the spacer between the masking layers out of the area subjected to the electrochemical forming; and cutting the metal materials in the space between the first and second masking layers.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael M. Trinh whose telephone number is (571) 272-1847. The examiner can normally be reached on M-F: 8:30 Am to 5:00 Pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amir Zarabian can be reached on (571) 272-1852. The fax phone numbers for the organization where this application proceeding is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

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Michael Trinh Primary Examiner